,	Search Notes			

Application/Control No.	Applicant(s)/Patent unde Reexamination
10/516,912	HORIUCHI ET AL.
Examiner	Art Unit

3746

Patrick Hamo

SEARCHED				
Class	Subclass	Date	Examiner	
417	42	12/12/2006	PH	
417	44.1	12/12/2006	PH	
417	44.2	12/12/2006	PH	
417	287	12/12/2006	PH	
			-	

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
	-			

SEARCH N (INCLUDING SEARC		)
	DATE	EXMR
417/42, 44.1, 44.2, and 287 recommended by M Kozco	12/12/2006	PH
·		
· .		